

40 C.F.R. § 53.61

Test conditions.

- (a) Sampler surface preparation. Internal surfaces of the candidate sampler shall be cleaned and dried prior to performing any Class II sampler test in this subpart. The internal collection surfaces of the sampler shall then be prepared in strict accordance with the operating instructions specified in the sampler's operating manual referred to in section 7.4.18 of 40 CFR part 50, appendix L.
- (b) Sampler setup. Set up and start up of all test samplers shall be in strict accordance with the operating instructions specified in the manual referred to in section 7.4.18 of 40 CFR part 50, appendix L, unless otherwise specified within this subpart.
- (c) Sampler adjustments. Once the test sampler or samplers have been set up and the performance tests started, manual adjustment shall be permitted only between test points for all applicable tests. Manual adjustments and any periodic maintenance shall be limited to only those procedures prescribed in the manual referred to in section 7.4.18 of 40 CFR part 50, appendix L. The submitted records shall clearly indicate when any manual adjustment or periodic maintenance was made and shall describe the operations performed.
- (d) Sampler malfunctions. If a test sampler malfunctions during any of the applicable tests, that test run shall be repeated. A detailed explanation of all malfunctions and the remedial actions taken shall be submitted as part of the equivalent method application.
- (e) Particle concentration measurements. All measurements of particle concentration must be made such that the relative error in measurement is less than 5.0 percent. Relative error is defined as ($s \times 100 \text{ percent}$)/(X), where s is the sample standard deviation of the particle concentration detector, X is the measured concentration, and the units of s and X are identical.

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